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Applicant: Shenzhen Slkormicro Semicon Co., Ltd.

: 2010, Block A, Bairuida Building Vanke City Community Bantian Avenue,

Address

Longgang District, Shenzhen, Guangdong, China.

Manufacturer : Shenzhen Slkormicro Semicon Co., Ltd.

: 2010, Block A, Bairuida Building Vanke City Community Bantian Avenue,

Address

Longgang District, Shenzhen, Guangdong, China.

The following sample(s) was /were submitted and identified on behalf of the clients as:

Trade Mark : Slkor

Sample Name : Semiconductor power devices

Sample Model : ZMM12, LL-34, LL-41

Sample Received Date : May 11, 2024

Testing Period : May 12, 2024 To May 16, 2024

: Total Lead (Pb), Cadmium(Cd), Phthalates(7P) content according to California

Test Requested

Proposition 65

Test Method : Please refer to next page(s).

Test Result : Please refer to next page(s).

Conclusion : PASS (Based on test results)

Signed for and on behalf of



Tony Qian/ Technical Director

This report is only responsible for the test results of the samples submitted for inspection, and is not responsible for the source of the samples submitted for inspection.

This report shall not be altered, increased or deleted. Without written approval of KEYS, this test report shall not be copied except in full and published as advertisement.

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Sample Description:

No.	Name
1	Diode

Test method and Test equipment:

	Test Item	Test Method	Test Equipment			
	Lead(Pb)	IEC 62321-5:2013	ICP-AES			
Cadmium(Cd)		IEC 62321-5:2013	ICP-AES			
	Phthalate	CPSC-CH-C1001-09.4	GC-MS			



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Test Result:

Tost Itam(s)	IIn:4	Result				MDI	T ::4	
Test Item(s)	Unit	No.1					MDL	Limit
Cadmium(Cd)	mg/kg	N.D.					2	300
Lead(Pb)	mg/kg	N.D.					2	100
Dibutyl Phthalate(DBP)	mg/kg						30	1000
Di-(2-ethylhexyl) Phthalate (DEHP)	mg/kg						30	1000
Benzylbutyl Phthalate(BBP)	mg/kg						30	1000
Diisononyl Phthalate (DINP)	mg/kg						50	1000
Di-n-octyl Phthalate(DNOP)	mg/kg)			30	1000
Diisodecyl Phthalate (DIDP)	mg/kg						50	1000
Di-n-hexyl- phthalate(DnHP)	mg/kg			-	67 1	-	50	1000

Note: 1. mg/kg= ppm

- N.D.= Not Detected(<MDL)
- 3. MDL = Method Detection Limit
- -- = No Testing



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Sample photo:



*** End of Report ***

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